

### SWITCHING

### N-CHANNEL POWER MOS FET

#### DESCRIPTION

The  $\mu$ PA2702TP, which has a heat spreader, is N-Channel MOS Field Effect Transistor designed for DC/DC converter and power management applications of notebook computers.

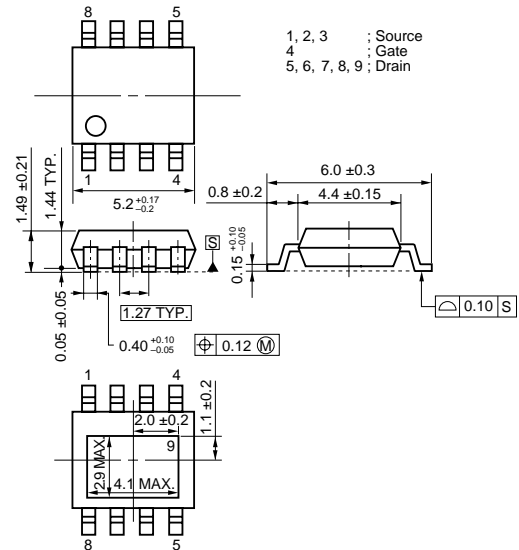
#### FEATURES

- Low on-state resistance  
 $R_{DS(on)1} = 9.5 \text{ m}\Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 7.0 \text{ A)}$   
 $R_{DS(on)2} = 15.1 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4.5 \text{ V, } I_D = 7.0 \text{ A)}$
- Low  $C_{iss}$ :  $C_{iss} = 900 \text{ pF TYP. (} V_{DS} = 10 \text{ V, } V_{GS} = 0 \text{ V)}$
- Small and surface mount package (Power HSOP8)

#### ORDERING INFORMATION

| PART NUMBER    | PACKAGE     |
|----------------|-------------|
| $\mu$ PA2702TP | Power HSOP8 |

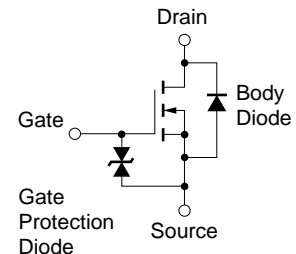
#### PACKAGE DRAWING (Unit: mm)



#### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ , Unless otherwise noted, All terminals are connected.)

|   |                |                        |                  |
|---|----------------|------------------------|------------------|
| Drain to Source Voltage ( $V_{GS} = 0 \text{ V}$ )                    | $V_{DSS}$      | 30                     | V                |
| Gate to Source Voltage ( $V_{DS} = 0 \text{ V}$ )                     | $V_{GSS}$      | $\pm 20$               | V                |
| Drain Current (DC) ( $T_C = 25^\circ\text{C}$ )                       | $I_{D(DC)1}$   | $\pm 35$               | A                |
| Drain Current (DC) ( $T_A = 25^\circ\text{C}$ ) <sup>Note1</sup>      | $I_{D(DC)2}$   | $\pm 14$               | A                |
| Drain Current (pulse) <sup>Note2</sup>                                | $I_{D(pulse)}$ | $\pm 65$               | A                |
| Total Power Dissipation ( $T_C = 25^\circ\text{C}$ )                  | $P_{T1}$       | 22                     | W                |
| Total Power Dissipation ( $T_A = 25^\circ\text{C}$ ) <sup>Note1</sup> | $P_{T2}$       | 3                      | W                |
| Channel Temperature   | $T_{ch}$       | 150                    | $^\circ\text{C}$ |
| Storage Temperature   | $T_{stg}$      | $-55 \text{ to } +150$ | $^\circ\text{C}$ |
| Single Avalanche Current <sup>Note3</sup>                             | $I_{AS}$       | 16                     | A                |
| Single Avalanche Energy <sup>Note3</sup>                              | $E_{AS}$       | 25.6                   | mJ               |

#### EQUIVALENT CIRCUIT



**Notes** 1. Mounted on a glass epoxy board (1 inch x 1 inch x 0.8 mm),  $PW = 10 \text{ sec}$

2.  $PW \leq 10 \mu\text{s}$ , Duty Cycle  $\leq 1\%$

★ 3. Starting  $T_{ch} = 25^\circ\text{C}$ ,  $V_{DD} = 15 \text{ V}$ ,  $R_G = 25 \Omega$ ,  $L = 100 \mu\text{H}$ ,  $V_{GS} = 20 \rightarrow 0 \text{ V}$

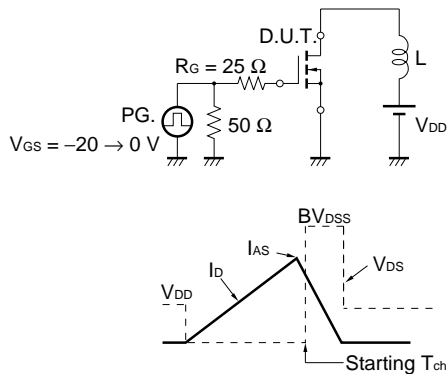
**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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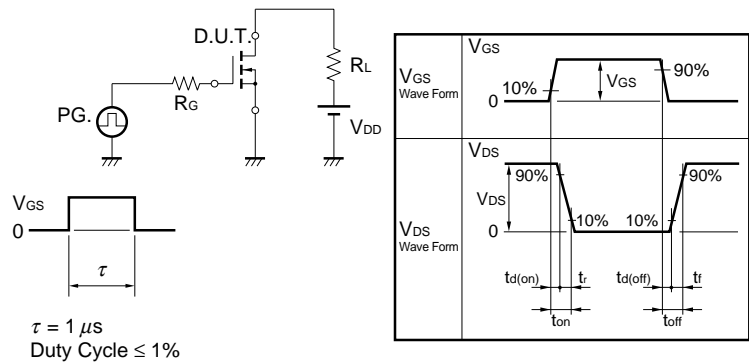
**ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C, Unless otherwise noted, All terminals are connected.)**

| CHARACTERISTICS                     | SYMBOL               | TEST CONDITIONS                                 | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current     | I <sub>DSS</sub>     | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V   |      |      | 10   | μA   |
| Gate Leakage Current                | I <sub>GSS</sub>     | V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V  |      |      | ±10  | μA   |
| Gate Cut-off Voltage                | V <sub>GS(off)</sub> | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA   | 1.5  | 2.0  | 2.5  | V    |
| Forward Transfer Admittance         | y <sub>fs</sub>      | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7.0 A  | 7    | 13   |      | S    |
| Drain to Source On-state Resistance | R <sub>DS(on)1</sub> | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7.0 A  |      | 7.6  | 9.5  | mΩ   |
|                                     | R <sub>DS(on)2</sub> | V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 7.0 A |      | 11.3 | 15.1 | mΩ   |
|                                     | R <sub>DS(on)3</sub> | V <sub>GS</sub> = 4.0 V, I <sub>D</sub> = 7.0 A |      | 12.9 | 17.2 | mΩ   |
| Input Capacitance                   | C <sub>iss</sub>     | V <sub>DS</sub> = 10 V                          |      | 900  |      | pF   |
| Output Capacitance                  | C <sub>oss</sub>     | V <sub>GS</sub> = 0 V                           |      | 380  |      | pF   |
| Reverse Transfer Capacitance        | C <sub>rss</sub>     | f = 1 MHz                                       |      | 120  |      | pF   |
| Turn-on Delay Time                  | t <sub>d(on)</sub>   | V <sub>DD</sub> = 15 V, I <sub>D</sub> = 7.0 A  |      | 9    |      | ns   |
| Rise Time                           | t <sub>r</sub>       | V <sub>GS</sub> = 10 V                          |      | 5    |      | ns   |
| Turn-off Delay Time                 | t <sub>d(off)</sub>  | R <sub>G</sub> = 10 Ω                           |      | 35   |      | ns   |
| Fall Time                           | t <sub>f</sub>       |   |      | 8    |      | ns   |
| Total Gate Charge                   | Q <sub>G</sub>       | V <sub>DD</sub> = 15 V                          |      | 9    |      | nC   |
| Gate to Source Charge               | Q <sub>GS</sub>      | V <sub>GS</sub> = 5 V                           |      | 3    |      | nC   |
| Gate to Drain Charge                | Q <sub>GD</sub>      | I <sub>D</sub> = 13 A                           |      | 4    |      | nC   |
| Body Diode Forward Voltage          | V <sub>F(S-D)</sub>  | I <sub>F</sub> = 13 A, V <sub>GS</sub> = 0 V    |      | 0.82 | 1.2  | V    |
| Reverse Recovery Time               | t <sub>rr</sub>      | I <sub>F</sub> = 13 A, V <sub>GS</sub> = 0 V    |      | 28   |      | ns   |
| Reverse Recovery Charge             | Q <sub>rr</sub>      | di/dt = 100 A/μs                                |      | 22   |      | nC   |

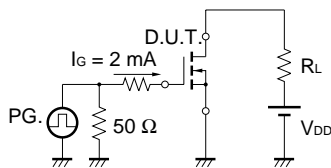
**TEST CIRCUIT 1 AVALANCHE CAPABILITY**



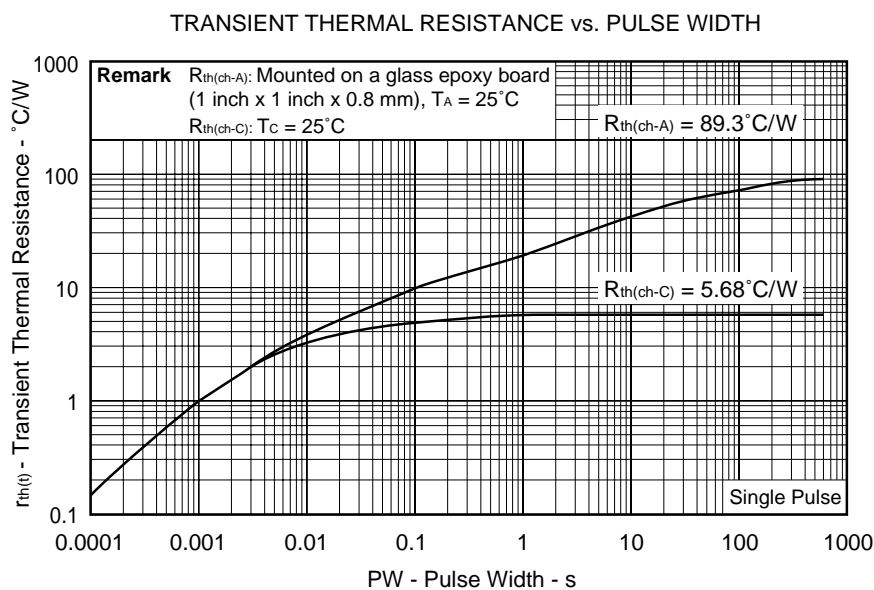
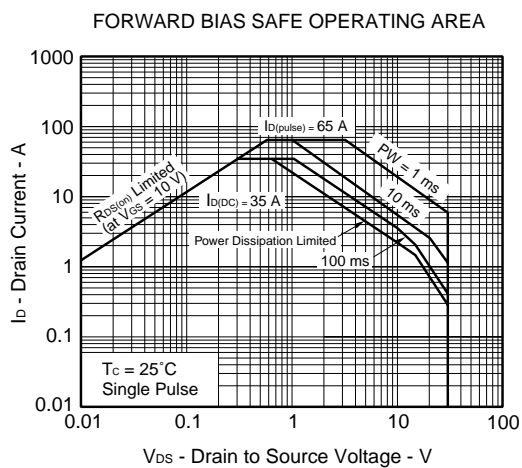
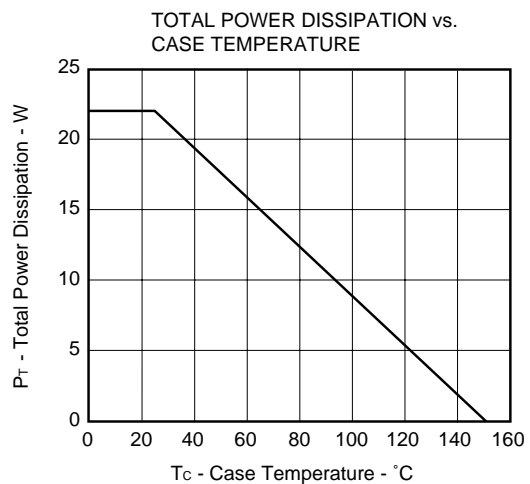
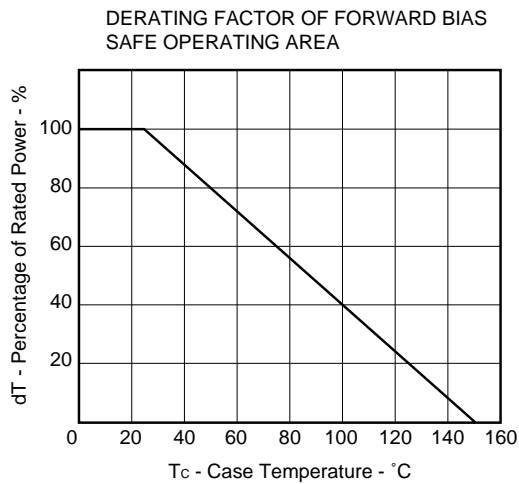
**TEST CIRCUIT 2 SWITCHING TIME**



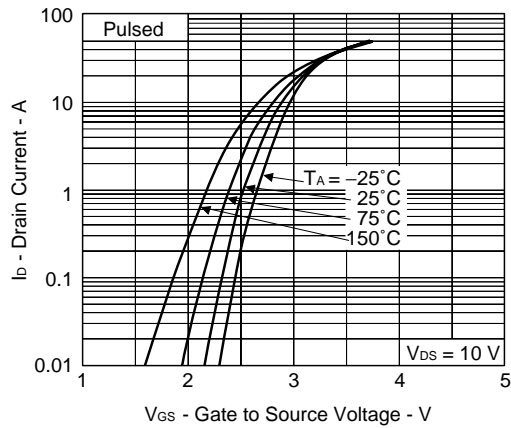
**TEST CIRCUIT 3 GATE CHARGE**



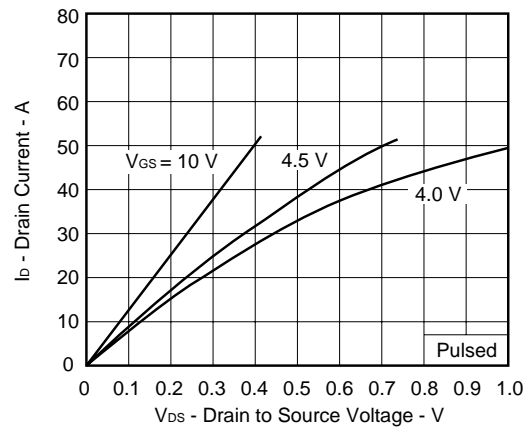
TYPICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ )



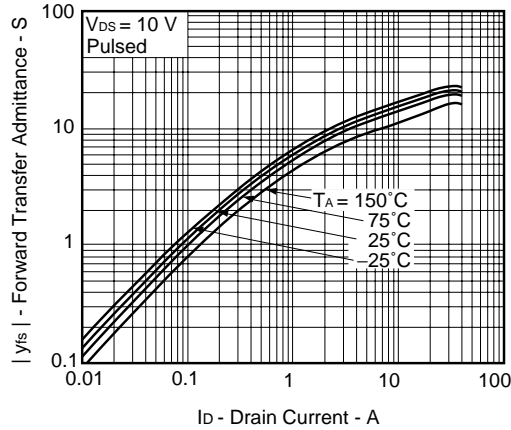
FORWARD TRANSFER CHARACTERISTICS



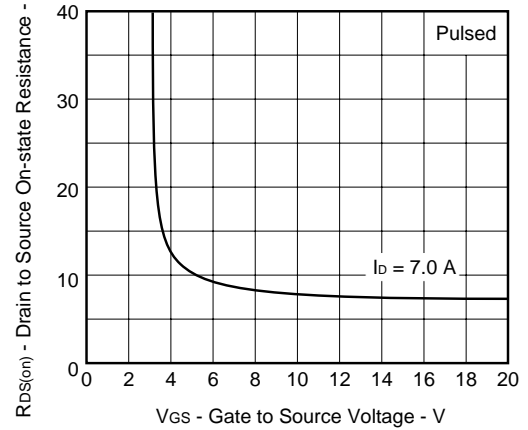
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



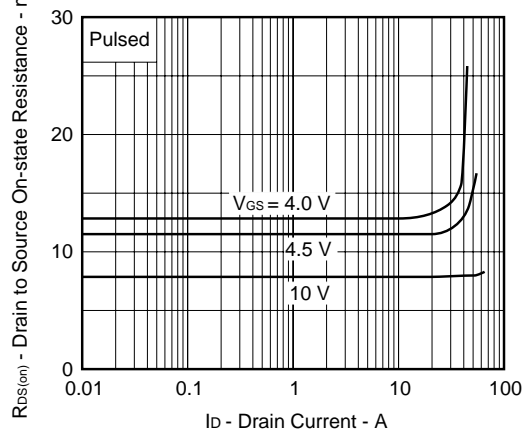
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



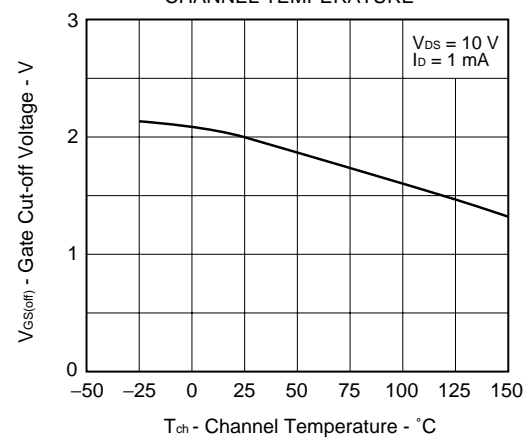
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

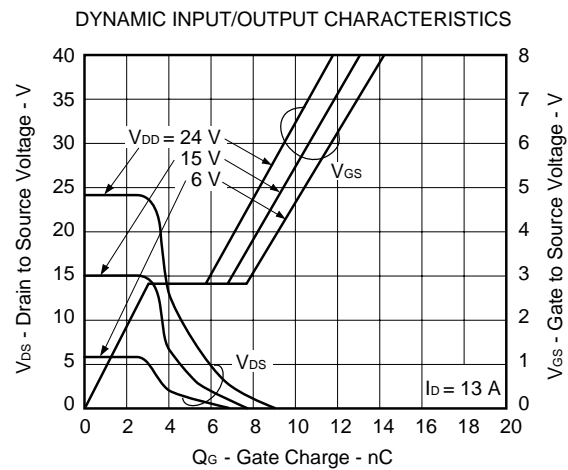
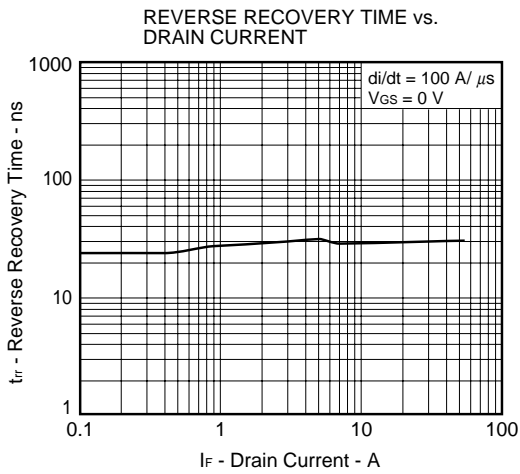
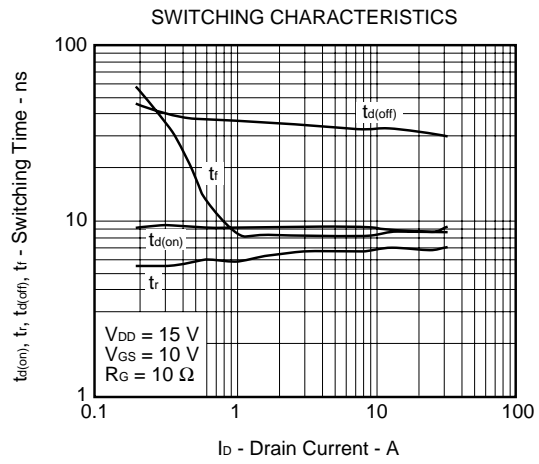
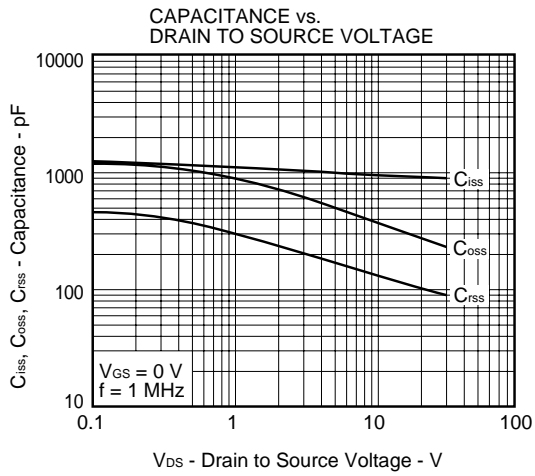
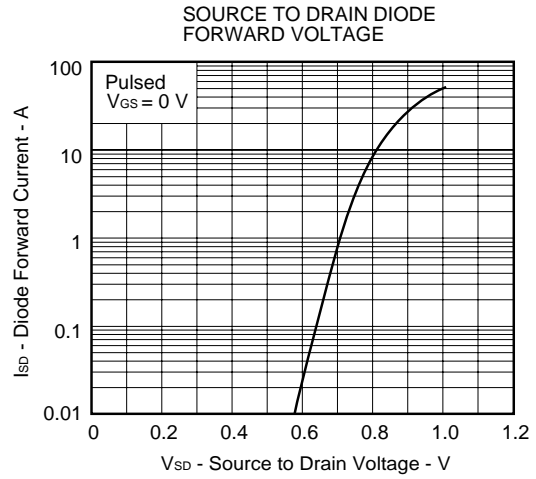
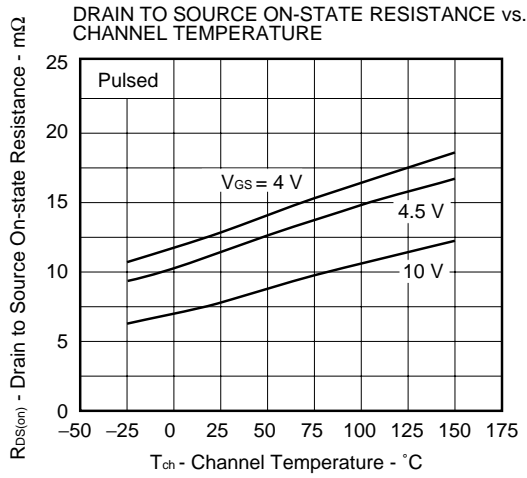


DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE





[MEMO]

[MEMO]

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